TOSHIBA

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE (π -MOS V)

2 S K 2 9 1 4

HIGH SPEED, HIGH CURRENT SWITCHING APPLICATIONS

CHOPPER REGULATOR, DC-DC CONVERTER AND MOTOR DRIVE **APPLICATIONS**

- Low Drain-Source ON Resistance : $R_{DS(ON)} = 0.42\Omega$ (Typ.)
- High Forward Transfer Admittance : $|Y_{fs}| = 7.5S$ (Typ.)
- Low Leakage Current

: $I_{DSS} = 100 \mu A$ (Max.) $(V_{DS} = 250V)$

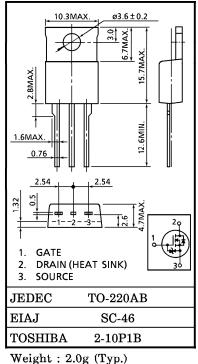
- : $V_{th} = 1.5 \sim 3.5 V$ Enhancement-Mode
 - $(V_{DS}=10V, I_{D}=1mA)$

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Drain-Source Voltage	V _{DSS}	250	V	
Drain-Gate Voltage (RGS	V _{DGR}	250	V	
Gate-Source Voltage	V _{GSS}	± 20	V	
Drain Current	DC	ID	7.5	А
	Pulse	I _{DP}	30	А
Drain Power Dissipation (T	PD	20	W	
Single Pulse Avalanche En	EAS	110	mJ	
Avalanche Current	I _{AR}	7.5	A	
Repetitive Avalanche Energ	EAR	2	mJ	
Channel Temperature	T _{ch}	150	°C	
Storage Temperature Range		T_{stg}	$-55 \sim 150$	°C

INDUSTRIAL APPLICATIONS

Unit in mm



THERMAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel to Case	R _{th (ch-c)}	6.25	°C/W
Thermal Resistance, Channel to Ambient	R _{th (ch-a)}	83.3	°C/W

Note :

* Repetitive rating ; Pulse Width Limited by Max. junction temperature.

** $V_{DD} = 50V$, Starting $T_{ch} = 25^{\circ}C$, L=3.3mH, $R_{G} = 25\Omega$, $I_{AR} = 7.5A$

This transistor is an electrostatic sensitive device. Please handle with caution.

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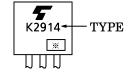
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

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CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		IGSS	$V_{GS} = \pm 16V, V_{DS} = 0V$	—	—	±10	μA
Drain Cut-O	ff Current	IDSS	$V_{DS}=250V, V_{GS}=0V$	—	_	100	$\mu \mathbf{A}$
Drain-Source Breakdown Voltage		V (BR) DSS	$I_D = 10 mA$, $V_{GS} = 0V$	250	_	–	v
Gate Thresh	old Voltage	V _{th}	$V_{DS} = 10V, I_D = 1mA$	1.5	—	3.5	V
Drain-Source	e ON Resistance	R _{DS} (ON)	$V_{GS} = 10V, I_D = 3.5A$	_	0.42	0.5	Ω
Forward Tra Admittance	nsfer	Y _{fs}	V _{DS} =10V, I _D =3.5A	4	7.5	-	s
Input Capacitance Reverse Transfer Capacitance		Ciss	V _{DS} =10V, V _{GS} =0V, f=1MHz	—	700	—	pF
		C _{rss}		-	80	-	
Output Capa	Output Capacitance			—	270	—	
Switching Time	Rise Time	tr	$V_{GS} \stackrel{10V}{}_{0V} \stackrel{ID=3.5A}{}_{0V} \stackrel{O}{}_{UUT} \stackrel{VOUT}{}_{RL=} \\ \stackrel{28.6\Omega}{}_{28.6\Omega} V_{DD} = 100V$	-	10	-	ns
	Turn-On Time	t _{on}		_	20	_	
	Fall Time	tf		_	10	_	
	Turn-Off Time	toff	$ \begin{array}{l} V_{IN}:t_r,\ t_f{<}5ns,\\ Duty \leq 1\%,\ t_w{=}10\mu s \end{array} $	_	70	-	
Total Gate Charge (Gate- Source Plus Gate-Drain)		$\mathbf{Q}_{\mathbf{g}}$	$V_{DD} \Rightarrow 200V, V_{GS} = 10V,$	_	20	_	
Gate-Source Charge		Q_{gs}	$I_{D} = 7.5 A$		13	-	nC
Gate-Drain ("Miller") Charge		$\mathbf{Q}_{\mathbf{gd}}$		—	7	—	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	I _{DR}	_	_	_	7.5	A
Pulse Drain Reverse Current	I _{DRP}	—	—	_	30	Α
Diode Forward Voltage	VDSF	$I_{DR} = 7.5A, V_{GS} = 0V$	—	—	-2.0	V
Reverse Recovery Time	t _{rr}	$I_{DR} = 7.5 A, V_{GS} = 0 V$	—	180	—	ns
Reverse Recovery Charge	Q_{rr}	$dI_{DR}/dt = 100 \text{Å}/\mu \text{s}$	_	1.1		μC

MARKING



% Lot Number

Month (Starting from Alphabet A)

– Year (Last Number of the Christian Era)

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